

tentative

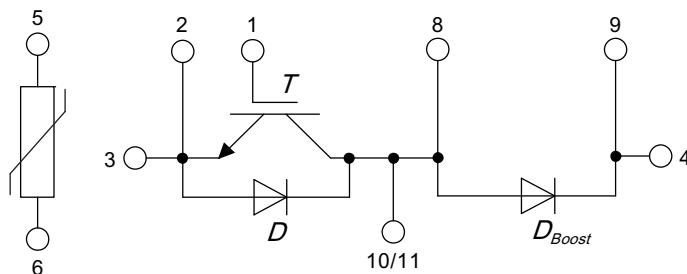
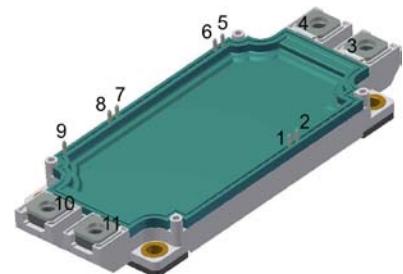
**XPT IGBT Module**

**V<sub>CES</sub>** = **1200 V**  
**I<sub>C25</sub>** = **360 A**  
**V<sub>CE(sat)</sub>** = **1.8 V**

Boost chopper + free wheeling Diodes + NTC

**Part number**

MIXA225RF1200TSF

**Features / Advantages:**

- High level of integration - only one power semiconductor module required for the whole drive
- Rugged XPT design (Xtreme light Punch Through) results in:
  - short circuit rated for 10  $\mu$ sec.
  - very low gate charge
  - low EMI
  - square RBSOA @ 3x I<sub>c</sub>
- Thin wafer technology combined with the XPT design results in a competitive low  $V_{CE(sat)}$
- Temperature sense included
- SONIC™ diode
  - fast and soft reverse recovery
  - low operating forward voltage

**Applications:**

- Brake for AC motor drives
- Boost chopper
- Switch reluctance drives

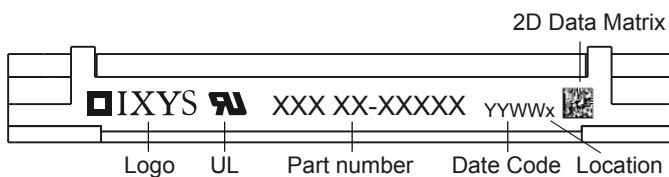
**Package:** SimBus F

- Industry standard outline
- RoHS compliant
- Soldering pins for PCB mounting
- Height: 17 mm
- Base plate: Copper internally DCB isolated
- Advanced power cycling

IGBT T			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{CES}$	collector emitter voltage	$T_{VJ} = 25^\circ\text{C}$ to $125^\circ\text{C}$			1200	V
$V_{GES}$	max. DC gate voltage				$\pm 20$	V
$V_{GEM}$	max. transient gate emitter voltage				$\pm 30$	V
$I_{C25}$	collector current	$T_C = 25^\circ\text{C}$			360	A
$I_{C80}$		$T_C = 80^\circ\text{C}$			250	A
$P_{tot}$	total power dissipation	$T_C = 25^\circ\text{C}$			1100	W
$V_{CE(\text{sat})}$	collector emitter saturation voltage	$I_C = 225 \text{ A}; V_{GE} = 15 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	1.8	2.1	V
			$T_{VJ} = 125^\circ\text{C}$	2.1		V
$V_{GE(\text{th})}$	gate emitter threshold voltage	$I_C = 9 \text{ mA}; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ\text{C}$	5.4	6.5	V
$I_{CES}$	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$		0.3	mA
			$T_{VJ} = 125^\circ\text{C}$		0.3	mA
$I_{GES}$	gate emitter leakage current	$V_{GE} = \pm 20 \text{ V}; V_{CE} = 0 \text{ V}$			1.5	$\mu\text{A}$
$Q_{G(\text{on})}$	total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 225 \text{ A}$			690	nC
$t_{d(on)}$	turn-on delay time	$V_{CE} = 600 \text{ V}; I_C = 225 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 3.3 \Omega$	$T_{VJ} = 125^\circ\text{C}$	60		ns
$t_r$	current rise time			70		ns
$t_{d(off)}$	turn-off delay time			280		ns
$t_f$	current fall time			310		ns
$E_{on}$	turn-on energy per pulse			20		mJ
$E_{off}$	turn-off energy per pulse			27		mJ
<b>RBSOA</b>	reverse bias safe operating area	$V_{GE} = \pm 15 \text{ V}; R_G = 3.3 \Omega$	$T_{VJ} = 125^\circ\text{C}$			
$I_{CM}$		$V_{CE\text{max}} = 1200 \text{ V}$			500	A
<b>SCSOA</b>	short circuit safe operating area	$V_{CE\text{max}} = 1200 \text{ V}$	$T_{VJ} = 125^\circ\text{C}$			
$t_{sc}$	short circuit duration	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 3.3 \Omega$ ; non-repetitive		900	10	$\mu\text{s}$
$I_{sc}$	short circuit current				A	
$R_{thJC}$	thermal resistance junction to case				0.115	K/W
$R_{thCH}$	thermal resistance case to heatsink				0.045	K/W
Diode $D_{Boost}$						
$V_{RRM}$	max. repetitive reverse voltage		$T_{VJ} = 25^\circ\text{C}$		1200	V
$I_{F25}$	forward current		$T_C = 25^\circ\text{C}$		265	A
$I_{F80}$			$T_C = 80^\circ\text{C}$		185	A
$V_F$	forward voltage	$I_F = 225 \text{ A}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	1.80	2.10	V
			$T_{VJ} = 125^\circ\text{C}$	1.70		V
$I_R$	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ\text{C}$		0.3	mA
			$T_{VJ} = 125^\circ\text{C}$			mA
$Q_{rr}$	reverse recovery charge	$V_R = 600 \text{ V}$ $-di_F/dt = 3300 \text{ A}/\mu\text{s}$ $I_F = 225 \text{ A}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 125^\circ\text{C}$	32		$\mu\text{C}$
$I_{RM}$	max. reverse recovery current			250		A
$t_{rr}$	reverse recovery time			340		ns
$E_{rec}$	reverse recovery energy			11.7		mJ
$R_{thJC}$	thermal resistance junction to case				0.145	K/W
$R_{thCH}$	thermal resistance case to heatsink				0.05	K/W

Diode D			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{RRM}$	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$			1200	V
$I_{F25}$	forward current	$T_C = 25^\circ C$			65	A
$I_{F80}$		$T_C = 80^\circ C$			45	A
$V_F$	forward voltage	$I_F = 60 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$		2.0	V
			$T_{VJ} = 125^\circ C$		2.0	V
$I_R$	reverse current * not applicable, see Ices value of IGBT T	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$		*	mA
			$T_{VJ} = 125^\circ C$		*	mA
$R_{thJC}$	thermal resistance junction to case				0.5	K/W
$R_{thCH}$	thermal resistance case to heatsink				0.2	K/W

Package SimBus F			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$I_{RMS}$	RMS current	per terminal				A
$T_{stg}$	storage temperature		-40		125	°C
$T_{VJM}$	virtual junction temperature		-40		150	°C
<b>Weight</b>				350		g
		$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			3400	V~
$M_D$	mounting torque (M5)		3		6	Nm
$M_T$	terminal torque (M6)		3		6	Nm
$d_{Spp/App}$	creepage distance on surface / striking distance through air	terminal to terminal	12.7			mm
$d_{Spb/Apb}$		terminal to backside	10.0			mm
$V_{ISOL}$	isolation voltage	$t = 1 \text{ second}$		3000		V
		$t = 1 \text{ minute}$		2500		V
$R_{term-chip}$	resistance terminal to chip	$V = V_{CEsat} + 2x R_{term-chip} \cdot I_C$ resp. $V = V_F + 2x R \cdot I_F$		0.65		mΩ

**Part number**

M = Module  
I = IGBT  
X = XPT  
A = standard  
225 = Current Rating [A]  
RF = Boost / brake chopper + free wheeling diode  
1200 = Reverse Voltage [V]  
T = NTC  
EH = E3-Pack

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXA225RF1200TSF	MIXA225RF1200TSF	Box	3	511581

Temperature Sensor NTC			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$R_{25}$	resistance	$T_C = 25^\circ C$	4.75	5.0	5.25	kΩ
$B_{25/50}$	temperature coefficient			3375		K

## Outlines SimBus F

